

Advanced Test Equipment Rentals www.atecorp.com 800-404-ATEC (2832)

Digital Phosphor Oscilloscopes / Digital Serial Analyzers / Mixed Signal Oscilloscopes



DPO70000B/DSA70000B/MSO70000 Series

Features & Benefits

- On All Four Channels Simultaneously
 - 20, 16, 12.5, 8, 6, and 4 GHz Bandwidth Models
 - Up to 50 GS/s Real-Time Sample Rate
 - Up to 250 Megasample Record Length with MultiView Zoom™ Feature for Quick Navigation
 - Fastest Waveform Capture Rate with >300,000 wfms/s maximum per channel
- Highest Bandwidth Up to 20 GHz enables measurement on the latest high-speed serial standards
- Superior Signal Integrity and Excellent Signal-to-Noise Ratio Observe the truest representation of your waveform
- Pinpoint[®] Triggering Minimize time spent trying to acquire problem signals for efficient troubleshooting and shortened debug time

- 5 Gb/s Real-time Serial Trigger Assures triggering on the first instance of a specified NRZ or 8b/10b pattern to allow isolation of pattern-dependent effects
- Search & Mark Provides waveform pattern matching and software triggers for signals of interest
- 16 Logic Channels with 80 ps Timing Resolution for Debug of Digital and Analog Signals (MSO70000 only)
- P7500 TriMode[™] Probing System Perfectly matched signal connectivity from 4 GHz to 20 GHz
- Application Support for High-speed Serial Industry Standards, RF, Power Supplies and Memory – Enables standard-specific certification, measurement automation, and ease of use
- P6780 and P6717 High Performance 17 Channel Logic Probes with Bandwidths up to 2.5 GHz for Connections to Today's Fast Digital Signals (MSO70000 only)

Applications

- Design Verification including Signal Integrity, Jitter, and Timing Analysis
- Design Characterization for High-speed, Sophisticated Designs
- Certification Testing of Serial Data Streams for Industry Standards
- Memory Bus Analysis and Debug
- Prototype Turn-on and Power Supply Verification
- Research and Investigation of Transient Phenomena
- Production Testing of Complex Systems
- Spectral Analysis of Transient or Wide-bandwidth RF Signals





P7500 TriMode probes simplify complex measurement setups.



P6780 Differential Logic Probes provide high-bandwidth connections for up to 16 digital signals.

Tools for Your Complete Design Cycles

Tektronix understands that engineers rely on an oscilloscope throughout their design cycle, from prototype turn-on to production testing. The DPO/DSA70000B and MSO70000 Series oscilloscopes' unique capabilities combined with exceptional signal acquisition performance and analysis accelerate your measurement tasks.

Unmatched Acquisition and Signal-to-Noise Performance

The superior signal integrity and excellent signal-to-noise ratio of the DPO/DSA70000B and MSO70000 Series ensures confidence in your measurement results.

- High bandwidth, up to 20 GHz, matched across 4 channels
- Bandwidth enhancement eliminates imperfections in frequency response all the way to the probe tip. The user-selectable filter for each channel provides magnitude and phase correction for more accurate representation of extremely fast signals. In addition, only Tektronix allows the user to disable the bandwidth enhancement for applications needing the highest measurement throughput
- Simultaneous high sample rate on all channels captures more signal details (transients, imperfections, fast edges)
 - 50 GS/s on all analog channels for the 12.5, 16, and 20 GHz models
 - 25 GS/s on all analog channels for the 4, 6, and 8 GHz models
 - 12.5 GS/s on all logic channels in the MSO70000 Series
- Lowest jitter noise floor and highest vertical accuracy provide additional margin in your measurements
- Long record length provides high resolution and extended-duration waveform capture
 - Standard 10 MS per channel on the DPO70000B and MSO70000 Series and 20 MS on the DSA70000B Series
 - Optional up to 125 MS on all four channels for the 4, 6, and 8 GHz models
 - Optional up to 250 MS on all four channels for the 12.5, 16, and 20 GHz models
 - On the MSO70000 Series, the record length of logic channels match the analog record lengths for uncompromised analog and digital acquisition
 - MultiView Zoom helps you manage long records, compare and analyze multiple waveform segments
- With high signal-to-noise ratio and low internal noise floor, the DPO/DSA70000B and MSO70000 Series enable you to perform precise characterization measurements. When debugging a DUT, a low noise floor and maximum signal fidelity of the measurement instrument allows you to find the smallest anomalies that might affect the DUT's performance. For RF signals, a lower noise floor translates into a higher dynamic range, opening the DPO/DSA70000B and MSO70000 for a wider range of applications

Widest Range of Probing Solutions – Whether you need to measure 8 Gb/s serial data, fast digital logic, or switching currents from your new power supply design, Tektronix offers a vast array of probing solutions, including active single ended, differential, logic, high voltage, current, optical, and a wide range of probe and oscilloscope accessories.

Model	Analog Bandwidth	Analog Sample Rate 4 Channels	Standard Memory – Analog + Digital	Analog Channels	Logic Channels
DPO70404B	4 GHz	25 GS/s	10 MS	4	
DSA70404B	4 GHz	25 GS/s	20 MS	4	
MSO70404	4 GHz	25 GS/s	10 MS	4	16
DPO70604B	6 GHz	25 GS/s	10 MS	4	
DSA70604B	6 GHz	25 GS/s	20 MS	4	
MSO70604	6 GHz	25 GS/s	10 MS	4	16
DPO70804B	8 GHz	25 GS/s	10 MS	4	
DSA70804B	8 GHz	25 GS/s	20 MS	4	
MSO70804	8 GHz	25 GS/s	10 MS	4	16
DP071254B	12.5 GHz	50 GS/s	10 MS	4	
DSA71254B	12.5 GHz	50 GS/s	20 MS	4	
MSO71254	12.5 GHz	50 GS/s	10 MS	4	16
DPO71604B	16 GHz	50 GS/s	10 MS	4	
DSA71604B	16 GHz	50 GS/s	20 MS	4	
MSO71604	16 GHz	50 GS/s	10 MS	4	16
DPO72004B	20 GHz	50 GS/s	10 MS	4	
DSA72004B	20 GHz	50 GS/s	20 MS	4	
VISO72004	20 GHz	50 GS/s	10 MS	4	16

Quick Selection Guide

System Turn-on and Verification

From the time a design is first powered up through the initial operational checks, the DPO/DSA70000B and MSO70000 Series provide the features you need.

Uncompromised Four Channel Acquisition

With the industry's lowest noise and up to 50 GS/s sample rate on all four channels the DPO70000B Series ensures that signal integrity checks and timing analysis can be done without worrying about noise and jitter in the scope distorting the measurements. Single shot bandwidths up to 20 GHz on all four channels ensure that you'll capture your signals of interest without worrying about undersampling when using more than 1 or 2 channels.

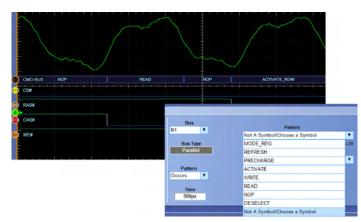
16 Channel Digital Acquisition (MSO70000 only)

When you have many interfaces to verify, the MSO70000 Series with 4 analog and 16 logic channels enables efficient channel-to-channel timing

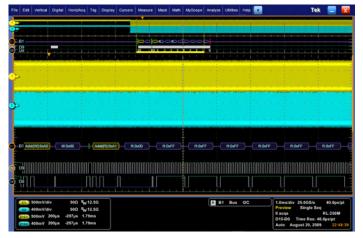
checks. With timing resolution of 80 ps, the MSO70000's digital acquisition system enables you to make precise timing measurements on as many as 20 channels simultaneously.

iCapture – One Connection for Analog and Digital (MSO70000 only)

The number of signals that must be verified can often make the checkout of a design long and involved. By using the iCapture digital-to-analog multiplexer feature, you can easily verify the analog characteristics of any of the 16 signals connected to the MSO70000 Series' digital channels. Using iCapture, you can quickly view the analog characteristics of any input channel. If the signal is working as expected, relegate it to a digital-only view and continue testing other lines.



Symbolic Bus Formats Simplify Identifying System States and Setting up Bus Triggers.



10 ms Duration Capture of Synchronous High-speed and Low-speed Signals at 25 GS/s.

Bus Decoding and Triggering (MSO70000 only)

Verifying your system operation often requires the ability to see specific system states on a key bus such as the DDR SDRAM interface. The MSO70000 includes parallel and low-speed serial bus decoding that provides deeper insight into the system's behavior. Using the bus triggering capability of the MSO70000 to isolate the exact state needed or find invalid

bus sequences is as easy as defining the bus and choosing the bit pattern or symbolic word that describes the desired state.

Deep Record Length Available on All Channels

Longer duration events such as power supply sequencing and system status words can be analyzed without sacrificing timing resolution using the long memory depths available on all four analog channels in the DPO/DSA70000B Series as well as the 16 logic channels of the MSO70000 Series. Optional memory depths up to 125 MS (Option 10XL) on the 4, 6, and 8 GHz models and 250 MS (Option 20XL) on the 12.5, 16, and 20 GHz models are available.

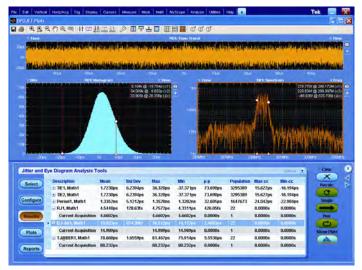
Power supplies can be a critical failure point in any system. Careful testing of the power delivery system's power on sequence can be time consuming. The MSO70000 provides independent logic thresholds for each logic channel enabling multiple logic voltages to be set up and observed simultaneously for quick verification of the system's power rails.

Protocol and Serial Pattern Triggering

To verify serial architectures, the serial pattern triggering for NRZ serial data streams with built-in clock recovery in the DPO/DSA70000B and MSO70000 Series allows correlating events across physical and link layers. The instruments can recover the clock signal, identify transitions, and allow you to set the desired encoded words for the serial pattern trigger to capture. This feature comes standard on the DSA70000B Series and is available on DPO70000B and MSO70000 models as Option PTH. Option PTH and the DSA70000B Series cover serial standards up to 3.125 Gb/s. For higher bit rate standards like USB 3.0, Option PTU on the DPO70000B Series and option STU on the DSA70000B Series extend 8b10b triggering and decode to 5 Gb/s.

Pattern Lock Triggering adds an extra dimension to NRZ serial pattern triggering by enabling the oscilloscope to take synchronized acquisitions of a long serial test pattern with outstanding time base accuracy. Pattern lock triggering can be used to remove random jitter from long serial data patterns. Effects of specific bit transitions can be investigated, and averaging can be used with mask testing. Pattern Lock Triggering supports up to 6.25 Gb/s NRZ serial data stream and is standard on the DSA70000B instruments, or is included as part of Option PTH on the DPO70000B and MSO70000 models.

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DPOJET Jitter And Eye Diagram Analysis – Simplify identifying signal integrity concerns, jitter, and their related sources with DPOJET software. DPOJET provides the highest sensitivity and accuracy available for real-time oscilloscopes.

System Characterization and Margin Testing

When a design is working correctly and the next task is to fully characterize its performance, the DSA70000B Series offers the industry's most comprehensive set of analysis and certification tools, such as math expressions, waveform mask testing, pass/fail testing, event searching, and event marking. Tools for automation reduce the tedium and speed up the process of making hundreds of characterization measurements.

Advanced Waveform Analysis

Full analysis of the power, voltage, and temperature corners of your system under test can be very time consuming. The DPO/DSA70000B and MSO70000 Series offer a wide range of built-in advanced waveform analysis tools.

Waveform cursors make it easy to measure trace-to-trace timing characteristics, while cursors that link between YT and XY display modes make it easy to investigate phase relationships and Safe Operating Area

violations. Select from 53 automatic measurements using a graphical palette that logically organizes measurements into Amplitude, Time, Histogram, and Communications categories. Gather further insight into your measurement results with statistical data such as mean, min, max, standard deviation, and population.

Define and apply math expressions to waveform data for on-screen results in terms that you can use. Access common waveform math functions with the touch of a button. Or, for advanced applications, create algebraic expressions consisting of live waveforms, reference waveforms, math functions, measurement values, scalars, and user-adjustable variables with an easy-to-use calculator-style editor.

With deep acquisition memory, margin testing can be done over many cycles and long duration trends in the data can be observed. Plus, data from the oscilloscope can be captured into Microsoft Excel using the unique Excel toolbar, and formatted into custom reports using the Word toolbar provided with the DPO/DSA70000B and MSO70000 products.

Automated Tools to Increase Measurement Throughput

Ease of use and measurement throughput are key when a large number of measurements must be completed with a performance oscilloscope. The DSA70000B comes standard with the DPOJET Advanced Jitter and Eye Diagram measurement application, providing the tools you need to quickly perform a high volume of measurements and collect statistics. DPOJET is available on the DPO70000B and MSO70000 as Option DJA. Application specific measurement packages are also available that extend DPOJET and perform the extensive set of tests required by industry standard groups.

RF and Vector Signal Analysis

When vector signal analysis of RF or baseband signals are needed the optional SignalVu application enables measurements in multiple domains (frequency, time, phase, modulation) simultaneously. SignalVu measurements are fully correlated with the scope's time domain acquisition and triggering. Time domain events, such as commands to a RF subsystem, can be used as trigger events, while the subsystem's RF signal can be seen in the frequency domain.

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DJ	16.399ps	36.000ps	NA	69.601ps , NA	Pass
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RJ	822.085fs	3.290ps	NA.	2.468ps , NA	Pass
Cdr-Slew-Max	-1.871us/s	10.000ms/s	NA	10.002ms/s , NA	Pass
TJ	27.908ps	132.000ps	NA	104.092ps , NA	Pass
UI	200.392ps	201.060ps	199,940ps	667.767fs , 452.233fs	Pass
VTx-Diff-PP	439.104mV	1.200V	100.000mV	760.896mV , 339.104mV	Pass
width@BER	172.877ps	NA	68.000ps	NA , 104.877ps	Pass
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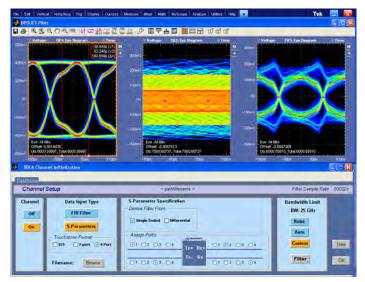
TekExpress USB 3.0 Automated Test Software (Option USB-TX) – TekExpress USB 3.0 provides an automated, simple, and efficient way to test USB 3.0 Transmitter hosts and devices consistent with the requirements of the SuperSpeed Universal Serial Bus Electrical Compliance Test Specification. The application automates selection of appropriate CTLE and reference channel emulation filters and measurement selections based on device type, test type, test points, and selected probes. In addition, USB-TX leverages DPOJET allowing for debug and advanced characterization of USB 3.0 solutions.

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TekExpress SATA Automated Compliance Test Software – Complete support for SATA Gen1 and SATA Gen2 defined test suites. Reduce your compliance test time by approximately 70% with simple, efficient automation of all required test suites with TekExpress software. Also included is auto-recognition of all required test equipment, precise DUT/Host control, and one-button testing.

TekExpress[™] Software Automation Framework

The TekExpress software automation framework has been developed for automated one-button testing of high-speed serial data standards. Built on top of National Instruments TestStand product, TekExpress efficiently executes the required tests for many serial standards like SATA Rev 3.0,



SDLA - Serial Data Link Analysis (options SLE and SLA) – Offers the capability to emulate the serial data channel, de-embed a fixture or other network, and add or remove transmitter equalization. Option SLA adds processing of waveforms with FFE and DFE equalizations and automatic equalizer training. DPOJET provides advanced measurement and jitter analysis of the resulting waveforms.

USB 3.0, DisplayPort and 10GBase-T Ethernet. Run on an external Windows PC, the TekExpress SATA software orchestrates the instrument setup and control sequences to provide complete test results for complete design validation.

Beyond using the TekExpress framework, custom applications that you develop yourself using application development environments such as MATLAB[®] can further extend the tool set of the DPO/DSA70000B and MSO70000 Series.

Characterization measurements depend upon accuracy and repeatability. The wide bandwidth and unmatched signal fidelity of the DPO/DSA70000B and MSO70000 analog front end ensures that your signal quality measurements such as rise times are faithful with capture of the signal's 5th harmonic and flatness of ± 0.5 dB.

Custom Filter and De-Embed Capability

Create your own filters or use the filters provided as standard with the DPO/DSA70000B and MSO70000 Series to enhance your ability to isolate or remove a component of your signal (noise or specific harmonics of the signal). These customizable FIR filters can be used to implement signal-processing techniques, such as removing signal pre-emphasis or minimizing the effects of fixtures and cables connected to the device under test. Using the optional Serial Data Link Analysis (SDLA) application, you can gain further insight into serial data links with the capability to emulate the serial data channel from its S-parameters, de-embed the fixture or other network, and add or remove transmitter equalization (de-emphasis).

Certification

Before a product can go to market, you often need to complete a series of certification tests on the industry-standard high-speed serial buses in your design. These tests can involve many hours of wrestling with test fixtures, reading certification documents and collecting sufficient data to validate that your system passes the required tests.

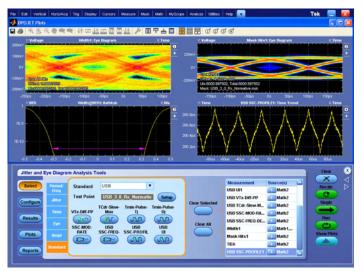
Application Specific Solutions – Enable Standard Specific Certification, Measurement Automation, and Extended Signal Analysis

Accurate, Simple, and Customizable Physical Layer Certification Testing – For designers with industry-standard certification needs, standard-specific compliance and analysis modules that configure the pass/fail waveform mask and measurement limit testing are available as options to the DPO/DSA70000B and MSO70000. Modules are available for PCI Express, DDR Memory, Serial ATA and SAS, InfiniBand, HDMI, Ethernet, DisplayPort, DVI, UWB, MIPI® D-PHY, Power Supplies, and USB.

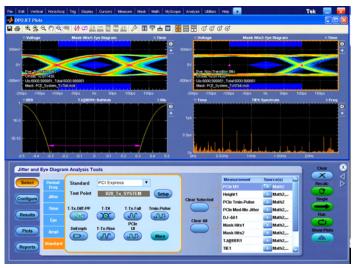
See the following list for highlights of the available application-specific solutions.



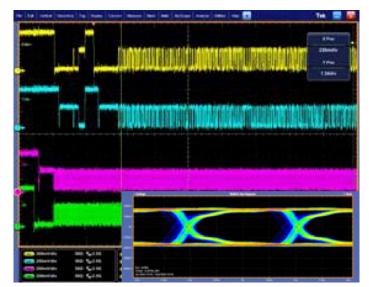
DDR Memory Bus Analysis (Option DDRA) – Automatically identify DDR1, LPDDR1, LPDDR2, DDR2, DDR3, and GDDR3 Reads and Writes and makes JEDEC conformance measurements with pass/fail results on all edges in every Read and Write burst. DDRA also provides capabilities for measurements of clock, address, and control signals. In addition to enabling conformance testing DDRA with DPOJET is the fastest way to debug complex memory signaling issues.



USB 3.0 Transmitter Test Solution (Option USB3) – Perform verification, characterization, and debug of USB 3.0 devices. Measurements are implemented in DPOJET and are compliant to the USB 3.0 specification. For compliance and automation, USB-TX is available, which also includes Option USB3.



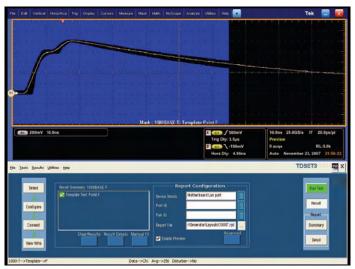
PCI Express Analysis Test Solution (Option PCE) – Analyze the performance of your PCI-Express Rev 1.0, 2.0, or 3.0 (draft spec) design with comprehensive test support. Using DPOJET, Option PCE enables tests that conform to PCI-SIG standards.



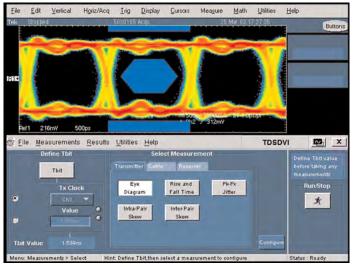
MIPI® D-PHY Transmitter Characterization and Compliance Test Solution – Verify to the D-PHY specification, rapidly characterize and discover sources of jitter and signal integrity concerns. Perform high-speed data-clock timing measurements, along with other electrical characteristics in high-speed or low-power modes.



XGbT 10GBase-T Automated Compliance Software – Quickly perform 10GBase-T measurements per the IEEE 802.3an-2006 standard including Power Spectral Density (PSD), Power Level, and Linearity, with a simplified instrument configuration. XGbT provides flexible control over test configurations and analysis parameters, enabling more in-depth device characterization.



Ethernet Compliance Test Solution (Option ET3) – Receive full PHY layer support for Ethernet variants 10Base-T, 100Base-TX, and 1000Base-T with Tektronix' comprehensive, integrated Ethernet tool set. Analog verification, automated compliance software, and device characterization solutions are all included.

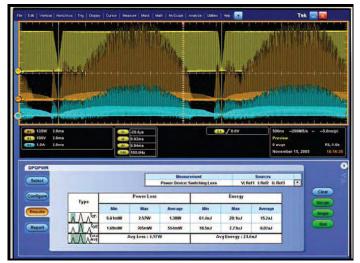


DVI Compliance Test Solution (Option DVI) – Obtain quick and dependable results with the DVI compliance test software. Automated testing based on pass/fail detection dramatically enhances productivity.

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Data Source	Supported Signal Types
Connected Device Under Test Stored Waveform Files	Pattem
	Pre-emphasis
Diff Probe Lane Assignment	🛛 🗹 0 dB 🗹 3.5 dB
CH1/Lane0	🖾 6 dB 🖾 9.5 dB
CH2/Lane1	⊂ Data Rate
CH3/Lane2	✓ 2.7G (HBR)
CH4/Lane3	☑ 1.62G (RBR)
	C Voltages
Instrument Configuration	✓ 400mV ✓ 800mV
CH1 Connection: OK	☑ 600mV ☑ 1200mV
CH2 Connection: OK	
CH3 Connection: OK	SSC With SSC Without SSC
CH4 Connection: OK	Villihout SSC
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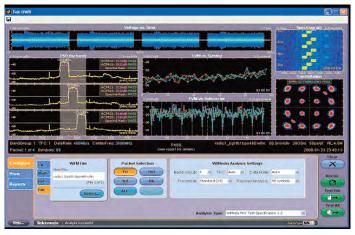
DisplayPort Compliance Test Solution (Option DSPT) – Support DisplayPort Compliance Test Standard (CTS) source test with four-line simultaneous testing using the Tektronix P7300SMA Series probes and DisplayPort software. Detailed test reports with waveform plots, pass/fail results, and margin analysis are included.



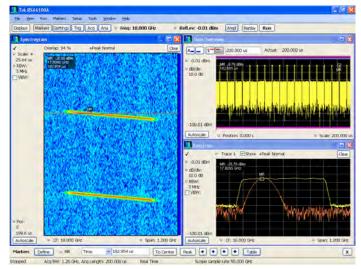
Power Measurement and Analysis Software (Option PWR) – Improve the efficiency of switching power supplies with increased power densities. Measure and analyze power dissipation in power supply switching devices and magnetic components, and generate detailed test reports in customizable formats.

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HDMI Compliance Test Solution (Option HT3) – Fast, efficient solution for HDMI compliance measurement challenges, no matter if you are working on a Source, Cable, or Sink solution. This application provides all the HDMI compliance test solutions you need to ensure quality and interoperability.



Ultra Wideband Spectral Analysis Software (Option UWB) – Analyze hundreds of packet, TFC, and data-rate combinations. In addition, the automatic WiMedia modulation analysis configuration will analyze how complex wideband signals change frequency and amplitude with time using real-time spectrograms spanning 20 GHz.



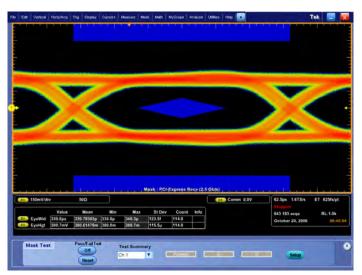
SignalVu[™] Vector Signal Analysis – Easily verify wide-bandwidth designs such as wideband radar, high data rate satellite links, or frequency-hopping radios and characterize wideband spectral events. SignalVu combines the functionality of a vector signal analyzer, a spectrum analyzer, and the powerful triggering capabilities of the DPO/DSA70000B and MSO70000 – all in a single package.

DSA70000B – A Dedicated Solution Configured for Today's High-speed Serial Design Challenges

The DSA70000B Digital Serial Analyzer is specially configured to address high-speed serial data designs by encapsulating many of the serial domain features needed for high-speed serial verification and characterization. These standard features on the DSA70000B Series are options on the DPO70000B and MSO70000 Series.

Serial Pattern Triggering – Real-time serial pattern triggering and protocol decode with built-in clock recovery recovers the clock signal, identifies the transitions, and decodes characters and other protocol data. You can see the 8b/10b bit sequences decoded into their words for convenient analysis, or you can set the desired encoded words for the serial pattern trigger to capture. With Pattern Lock Triggering, the DSA70000B can synchronize to long serial test patterns up to 6.25 Gb/s and remove random jitter. The DSA70000B Series covers serial standards up to 3.125 Gb/s with an option to support up to 5 Gb/s (Option STU).

DPOJET Jitter, Timing, and Eye-diagram Analysis – The DSA70000B Series features the highest-accuracy jitter and timing measurements as well as comprehensive analysis algorithms. Tight timing margins demand stable, low-jitter designs. You can make jitter measurements over contiguous clock cycles on every valid pulse in a single-shot acquisition. Multiple measurements and trend plots quickly show system timing under variable conditions, including Random and Deterministic Jitter separation.



Communications Mask Testing

Communications Mask Testing – Provides a complete portfolio of masks for verifying compliance to serial communications standards. 156 masks for the following standards are supported – PCI Express, ITU-T/ANSI T1.102, Ethernet IEEE 802.3, ANSI X3.263, Sonet/SDH, Fibre Channel, InfiniBand, USB, Serial ATA, Serial Attached SCSI, IEEE 1394b, RapidIO, OIF Standards.

20 MS Record Length – 20 MS on all four channels provides a longer time sequence at high resolution. Optional record lengths up to 125 MS for the 4, 6, and 8 GHz models, 250 MS for the 12.5, 16 and 20 GHz models extend the acquisition time sequence.

Advanced Event Search and Mark – Finding important events such as fast or slow transitions, setup and hold violations, or logic patterns within a long-duration capture is made easy with the pattern matching and software triggering functionality of Event Search and Mark.

With standard features that extend the functionality of the Tektronix DPO70000B Series to address high-speed serial signal analysis and certification, the DSA70000B Series offers a specialized instrument that efficiently addresses your design challenges.

DSA Feature Set in the MSO70000

If you need to combine the functionality of the DSA70000B and the MSO70000, the DSA options for the MSO70000 provide the DSA's high-speed serial test features in an MSO (see Option DSAH or DSAU in the Ordering Information section below).

User-selectable Bandwidth Limit Filters

While wide bandwidth is needed to characterize your high-speed serial designs, certification testing can require a specific instrument bandwidth appropriate for the signal's data rate in order to correlate test results between different test labs. The DPO/DSA70000B and MSO70000 Series feature user-selectable bandwidth limiting filters. Using these bandwidth limit filters which range from 500 MHz to 19 GHz, you will ensure that your measurement is done using the bandwidth specified by the industry standard.

Debugging

Throughout the design cycle, DPO/DSA70000B and MSO70000 Series oscilloscopes provide the ability to debug malfunctioning subsystems and isolate the cause. Using FastAcq's high waveform capture rate, you can quickly identify signal anomalies that occur intermittently – saving minutes, hours, or even days by quickly revealing the nature of faults so sophisticated trigger modes can be applied to isolate them. Using Pinpoint triggers, infrequent events such as glitches or signal runts caused by bus contention or signal integrity issues can be captured, analyzed and then eliminated.

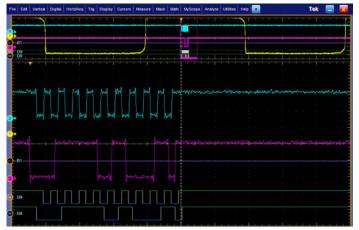
FastAcq – Expedites Debugging by Clearly Showing Imperfections

More than just color-grading or event scanning, FastAcq's proprietary DPX[®] acquisition technology captures signals at more than 300,000 waveforms per second on all four channels simultaneously, dramatically increasing the probability of discovering infrequent fault events. And with a simple turn of the intensity knob you can clearly "see a world others don't see", displaying the complete picture of your circuit's operation. Some oscilloscope vendors claim high waveform capture rates for short bursts of time, but only DPO/DSA70000B and MSO70000 oscilloscopes, enabled by DPX technology, can deliver these fast waveform capture rates on a sustained basis.

Pinpoint® Trigger

Whether you're trying to find a problem signal or need to isolate a section of a complex signal for further analysis, like a DDR read or write burst, Tektronix' Pinpoint triggering provides the solution. The Pinpoint trigger system uses Silicon Germanium (SiGe) technology to provide very high trigger sensitivity with very low trigger jitter and the ability to capture very narrow glitches. Pinpoint triggering allows selection of virtually all trigger types on both A and B trigger events delivering the full suite of advanced trigger reset capabilities that begin the trigger sequence again after a specified time, state, or transition so that even events in the most complex signals can be captured. Other oscilloscopes typically offer less than 20 trigger combinations; Pinpoint triggering offers over 1400 combinations, all at full performance.

With Enhanced Triggering, trigger jitter is reduced to <100 fs. With this stability at the trigger point, the trigger point can be used as a measurement reference.



Integrated Logic Channels – Provide time-correlated analog and digital visibility for system debugging.

Logic Pattern Triggering

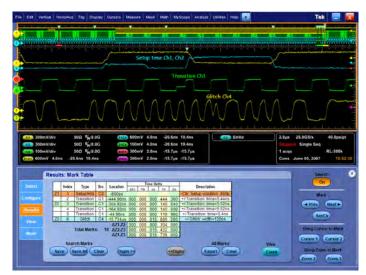
Logic pattern triggering allows logic qualification that controls when to look for the faults and ignore events that do not occur during the desired state. On the MSO70000 Series, up to 20 bit wide logic pattern triggering enhances the Pinpoint trigger capabilities by helping you isolate the specific system state and analog events that are causing system failure.

Integrated Logic Channels (MSO70000 only)

The MSO70000 extends the debug capabilities of a 4-channel oscilloscope with an additional 16 logic channels that can be used to provide system level context when the fault occurs. This context, such as an illegal system state or error, may be the clue that leads to the root cause. When other oscilloscopes require you to use a logic analyzer to see the digital data you need to solve your debugging challenge, the MSO70000 can effectively debug and verify many digital timing issues in the system more quickly and easily. With 80 ps timing resolution and channel-to-channel skews of as little as 160 ps, the integrated logic channels allow you to view and measure time-correlated digital and analog data in the same display window.

iCapture (MSO70000 only)

When an anomaly is seen on digital lines, iCapture delivers new insight into the analog behavior of the digital signals. With iCapture, you can route any 4 of the 16 logic channels to the MSO70000's analog acquisition system so that these signals can be viewed in finer detail. iCapture's unique multiplexer circuitry provides simultaneous digital and analog views of signals without having to move the logic probe or double probe the circuit.



Advanced Search and Mark – Highlights important events, skips unimportant ones, and navigates between events of interest effortlessly.

FastFrame

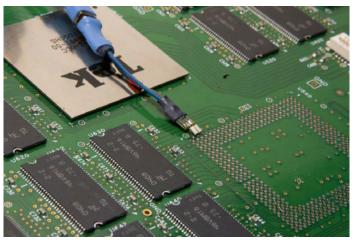
When the key events you are interested in are widely spaced in time, such as bursts of activity on a bus, FastFrame segmented memory feature on the DPO/DSA70000B and MSO70000 Series enables you to capture the events of interest while conserving acquisition memory. Using multiple trigger events, FastFrame captures and stores short bursts of signals and saves them as frames for later viewing and analysis. On the MSO70000, FastFrame and bus or logic triggering enable you to capture your fastest, bursty signals on the analog channels at the highest sample rate while the logic channel trigger recognizes the bus cycle of interest. Capturing thousands frames is possible, so long term trends and changes in the bursting signal can be analyzed.

Advanced Search and Mark

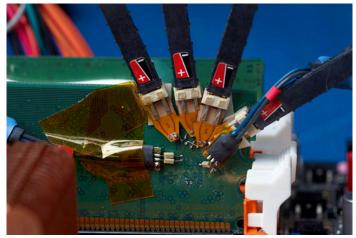
Isolating the key event causing your system failure can often be a tedious task. With the Advanced Event Search and Mark (Option ASM) feature examining data and highlighting important events, skipping the unimportant ones, and enhancing the comprehension of event relationships is made easy. With ASM, you'll be able to navigate between the events of interest effortlessly and uncover that rare event you have been trying to find.

Embedded Serial Bus (I²C, SPI) Decoding and Triggering (MSO70000 only)

The MSO70000 Series instruments provide I²C and SPI serial bus decoding and bus triggering that enable you to monitor or debug subsystems and components, such as frequency synthesizers, D/A converters, and Flash Memory that are controlled or monitored using I²C or SPI serial buses. While monitoring or debugging these serial buses alone is relatively easy, decoding events on the serial bus can also enable more complex system level debugging. When you experience an issue with a higher-speed serial interface, the clue to what is going wrong may be found by using the



The low-cost solder tips available for the P7500 TriMode probes allow quick connection so moving the probe to various solder points is fast and easy.



Solder tip accessories designed for the P6780 differential logic probes provide access to signals on tightly spaced vias and fine-pitched components.

MSO70000 Series bus decode feature to observe the data on your I²C or SPI interface.

Probing – Analog And Digital

Often the biggest challenge in debugging a system is getting access to the required signals. Tektronix offers a wide array of probing solutions, including the P7500 TriMode probing system with bandwidths that are perfectly matched to the DPO/DSA70000B and MSO70000 Series. The P7500 TriMode probes allow you to switch among differential, single-ended, and common-mode measurements without moving the probe from its connection points. The P7500 Series offers probes with performance from 4 GHz to 20 GHz and offers several low-cost solder tips with quick connection features that allow moving the probe to various solder points fast and easy.

On the MSO70000, the P6780 and P6717 logic probes provide connectivity to low-speed and high-speed digital signals with low loading, small size and a range of accessories for soldering and browsing.

Production Testing

In addition to assisting engineers with design tasks, the DPO/DSA70000B and MSO70000 can provide test engineers with the ability to test analog and digital signals with a wide range of clock speeds and data rates. Rackmount options are available for mounting the DPO/DSA70000B and MSO70000 into an EIA standard 19 inch (487 mm) rack. An IEEE 488.2 standard GPIB interface is standard on all models.

OpenChoice® Analysis Tools

The OpenChoice Software allows you to customize your test and measurement system with familiar analysis tools. The analysis and networking features of the OpenChoice software add more flexibility to Tektronix' DPO/DSA70000B and MSO70000 Series oscilloscopes: Using the fast embedded bus, waveform data can be moved directly from acquisition to analysis applications on the Windows desktop at much faster speeds than conventional GPIB transfers.

Tektronix' implementation of industry-standard protocols, such as TekVISA[™] interface and ActiveX controls, are included for using and enhancing Windows applications for data analysis and documentation. IVI instrument drivers are included to enable easy communication with the oscilloscope using GPIB, RS-232, and LAN connections from programs running on the instrument or an external PC. Or, use the Software Developer's Kit (SDK) to help create custom software to automate multistep processes in waveform collection and analysis with Visual BASIC, C, C++, MATLAB, LabVIEW, LabWindows/CVI, and other common Application Development Environments. Integration of the oscilloscope with external PCs and non-Windows hosts is also supported.

Research

With industry leading acquisition speed and signal-to-noise ratio performance, the DPO/DSA70000B and MSO70000 can provide researchers with tools that allow them to capture, display, and analyze high-speed and transient signals with unmatched precision.

Full Control of Acquisition and Display Parameters

You have full control of the instrument's acquisition modes. Choose the mode you need to do your job the fastest: Automatic, Constant Sample Rate, or Manual settings. When you are doing signal exploration and want a lively signal, the default Automatic mode provides you with the liveliest

display update rate. If you want the highest real-time sample rate that will give you the most measurement accuracy, then the Constant Sample Rate mode is for you. It will maintain the highest sample rate and provide the best real-time resolution. Finally the Manual mode ensures direct and independent control of the sample rate and record length for applications requiring specific settings.

TekLink™

When you need to capture a large number of signals simultaneously, TekLink allows you to synchronize multiple DPO/DSA70000B and MSO70000 oscilloscopes and acquire more than four channels. TekLink enables synchronized capture on up to 4 oscilloscopes with one trigger event.

Document Tools

The OpenChoice architecture provides a comprehensive software infrastructure for faster, more versatile operations. Data transfer utilities, such as the Excel or Word toolbar plug-ins can be used to simplify analysis and documentation on the Windows desktop or on an external PC.

Unmatched Usability

The DPO/DSA70000B Series instruments excel in usability with a suite of productivity features, such as a touch screen, flat menu structures, intuitive graphical icons, knob-per-channel vertical controls, right clicks, mouse wheel operation, and familiar Windows-based controls.

MyScope® – Create Your Own Control Windows

Easily create your own personalized "toolbox" of oscilloscope features in a matter of minutes using a simple, visual, drag-and-drop process. Once created, these custom control windows are easily accessed through a dedicated MyScope button and menu selection on the oscilloscope button/menu bar, just like any other control window. You can make an unlimited number of custom control windows, enabling each person who uses the oscilloscope in a shared environment to have their own unique control window. MyScope control windows will benefit all oscilloscope users, eliminating the ramp-up time that many face when returning to the lab after not using an oscilloscope for a while, and enables the power user to be far more efficient. Everything you need is found in one control window rather than navigating through multiple menus to repeat similar tasks.

Characteristics

Vertical System

Characteristic	DPO70404B DSA70404B MSO70404	DPO70604B DSA70604B MSO70604	DPO70804B DSA70804B MSO70804	DPO71254B DSA71254B MSO71254	DPO71604B DSA71604B MSO71604	DPO72004B DSA72004B MSO72004
Bandwidth (User-selectable DSP enhance)	4 GHz	6 GHz	8 GHz	12.5 GHz	16 GHz	20 GHz
Hardware Analog Bandwidth (-3 dB)	4 GHz	6 GHz	8 GHz	12.5 GHz	16 GHz (typical)	16 GHz (typical)
Input Channels	4	4	4	4	4	4
Logic Channels (MSO70000 only)	16	16	16	16	16	16
Rise Time 10% to 90% (Typical)	98 ps	65 ps	49 ps	32 ps	24.5 ps	19 ps
Rise Time 20% to 80% (Typical)	68 ps	45 ps	34 ps	22 ps	17 ps	14 ps
Vertical Noise (% of full scale) (Typical)*1	0.28%	0.32%	0.35%	0.38%	0.43%	0.77%
Bandwidth Limits	Depending		GHz, 18 GHz, 17 GHz, 1 ' GHz, 6 GHz, 5 GHz, 4 (z, 13 GHz, 12 GHz, 11 G GHz, or 500 MHz	Hz, 10 GHz,
Channel-to-Channel Isolation (Any two channels at equal vertical scale settings)	≥120:1 (0 GHz) ≥80:1 (for input f GHz to 15 GHz) ≥25:1 (f		2 GHz) ≥50:1 (for input fi GHz)	requency
DC Gain Accuracy			±2% (0f	reading)		
Delay between Any Two Channels (Typical)	≤100	ps for any two channels	with equal V/div and coup	oling settings ≤50 ps wit	h BW enhance enabled (E	3WE)
Effective Number of Bits (Typical)			5.4 b	its*2		
Input Coupling			DC (50 G	2), GND		
Input Impedance			50 Ω ±2%, 1 M Ω with	h TCA-1MEG adapter		
Input Sensitivity						
18 GHz and Below		1	0 mV/div to 500 mV/div (100 mV to 5 V full sca	e)	
20 GHz and 19 GHz			20 to 500 mV/div (200	mV to 5 V full scale)		
Max Input Voltage, 50 Ω			/div; also determined by 1			
Offset Accuracy 10 mV/div – 99.5 mV/div	\pm (0.35% (offset value-position) + 1.5 mV + 1% of full scale)					
100 mV/div – 500 mV/div.	\pm (0.35% (offset value-position) + 7.5 mV + 1% of full scale)					
Offset Range	10 mV/div: ±450 mV 20 mV/div: ±400 mV 50 mV/div: ±250 mV 100 mV/div: ±2.0 V 200 mV/div: ±1.5 V 500 mV/div: ±0.0 V					
Passband Flatness (20, 50, 100, 250 mV/div) (Typical)			± 0.5 dB to 50% of nomi			
Position Range			±5	div		
Vertical Resolution			8 bit (11 bit wi	ith averaging)		

*1 50 mV/div, bandwidth filter on.

 $^{\star 2}$ 50 mV/div, bandwidth filter on, max bandwidth up to 13 GHz, max sample rate.

Logic Channels (MSO70000 only)

Characteristic	MSO70404	MSO70604	MSO70804	MSO71254	MSO71604	MSO72004	
Input Channels	16						
Trigger Clock/Qualifier Input		1					
Analog Bandwidth							
With P6780 Logic Probe			2.5	GHz			
With P6717 Logic Probe			350	MHz			
Input Impedance							
With P6780 Logic Probe		20 k Ω to ground per side or 40 k Ω differential mode \pm 2.0%, 0.5 pF					
With P6717 Logic Probe		20 k Ω ± 1.0%, 3 pF					
Vertical Resolution			1	bit			
Threshold Levels			One per channel,	independently set			
Threshold Accuracy			±75 mV + 3% of	threshold setting			
Threshold Resolution			5	mV			
Logic Threshold Range							
With P6780 Logic Probe		-2 to +4.5V					
With P6717 Logic Probe		-1.5 to +4.0V					
Minimum Voltage Swing		300 mV _{p-p}					
Maximum Input Voltage			±15 V no	ondestruct			

Horizontal/Time Base System

Characteristic	DPO70404B DSA70404B MSO70404	DPO70604B DSA70604B MSO70604	DPO70804B DSA70804B MSO70804	DPO71254B DSA71254B MSO71254	DPO71604B DSA71604B MSO71604	DPO72004B DSA72004B MSO72004
Time Base Range		20 ps/div to 1000 s/div			10 ps/div to 1000 s/div	
Time Resolution (in ET/IT mode)		200 fs			100 fs	
Channel-to-Channel Deskew			Range	±75 ns		
Delta Time Measurement Accuracy RMS over <100 ns Duration; Single Shot; with Signal Rise Time = 1.2x Scope Rise Time	1.61 ps	1.29 ps	1.14 ps	940 fs	900 fs	1.02 ps
Jitter Noise Floor (Typical) (With BW bandwidth enhance enabled)	450 fs	450 fs	450 fs	300 fs	300 fs	400 fs
Time Base Accuracy			±1.5 ppm initial accuracy	, aging <1 ppm per yea	r	
Time Base Delay Time Range			–5.0 ks t	o 1.0 ks		
Trigger Jitter (RMS)			1 ps _{RMS} (typical) with er <100 fs _{RMS} with enha	nhanced triggering OFF anced triggering ON		

Acquisition System

Characteristic	DPO70404B DSA70404B MSO70404	DPO70604B DSA70604B MSO70604	DPO70804B DSA70804B MSO70804	DPO71254B DSA71254B MSO71254	DPO71604B DSA71604B MSO71604	DPO72004B DSA72004B MSO72004
Sample Rates						
Real-time Mode 1, 2, 3, or 4 Channel (Max)		25 GS/s			50 GS/s	
ET/IT Mode (Max)		5 TS/s			10 TS/s	
Maximum Record Le	ength per Channel					
With Standard Configuration With Record Length	10M on all four channels (DPO70000B and MSO70000 Series) 20M on all four channels (DSA70000B Series only) 20M on all four channels (DPO70000B and MSO70000 Series)					
Option 2XL		20101 0	IT all tour charmens (DPO)		Selles)	
With Record Length Option 5XL		50M on all four channels				
With Record Length Option 10XL			125M on all f	our channels		
With Record Length Option 20XL		N/A		250M on all four channels		S
Maximum Duration a	at Highest Real-Time	Resolution				
Timing Resolution		40 ps (25 GS/s)		20 ps (50 GS/s)		
Max Duration with Standard Memory	0.4 ms DPO7	0000B and MSO70000 for DSA70000B Series	Series; 0.8 ms	0.2 ms DPO70000B and MSO70000 Series; 0.4 ms for DSA70000B Series		Series; 0.4 ms
Max Duration with Option 2XL	0.8 ms (D	0.8 ms (DPO70000B and MSO70000 Series)		0.4 ms (DPO70000B and MSO70000 Series)		00 Series)
Max Duration with Option 5XL	2.0 ms			1.0 ms		
Max Duration with Option 10XL	5.0 ms			2.5 ms		
Max Duration with Option 20XL		N/A			5.0 ms	

Logic Channels (MSO70000 only)

Characteristic	MSO70404	MSO70604	MSO70804	MSO71254	MSO71604	MSO72004	
Sample Rate – All Channels (Max)			12.5	GS/s			
Timing Resolution		80 ps					
Displayed Channel-to-Channel Timing Uncertainty			<16	0 ps			
Maximum Record Length per Channel	125M	125M on all channels (Option 10XL)			on all channels (Option	20XL)	
Minimum Detectable Pulse Width			<40	10 ps			
Maximum Number of Buses				16			
Number of Channels per Bus			Up to 24 (16 logic	, 4 analog, 4 math)			

Acquisition Modes

Mode	Description
Averaging	From 2 to 10,000 waveforms included in average
Envelope	From 1 to 2×10 ⁹ waveforms included in min-max envelope
FastAcq	FastAcq optimizes the instrument for analysis of dynamic signals and capture of infrequent events
Maximum FastAcq Waveform Capture Rate	>300,000 wfms/s on all 4 channels simultaneously
FastFrame™	Acquisition memory divided into segments; maximum trigger rate >310,000 waveforms per second. Time of arrival recorded with each event. Frame finder tool helps to visually identify transients
Hi-Res	Real-time boxcar averaging reduces random noise and increases resolution
Peak Detect	Captures and displays narrow glitches at all real-time sampling rates: 1 ns at ≤125 MS/s; 1/sample rate at ≥250 MS/s
Roll Mode	Scrolls sequential waveform points across the display in a right-to-left rolling motion. Works at sample rates up to 10 MS/s with a maximum record length of 40 MS
Sample	Acquires and displays sampled values
Waveform Database	Accumulates waveform database providing three-dimensional array of amplitude, time, and counts

Pinpoint[®] Trigger System

Sensitivity	DPO and MSO Models	DSA Models			
Internal DC Coupled	4% of full scale from DC to 50 MHz 10% of full scale at 4 GHz 20% of full scale at 8 GHz 50% of full scale at 11 GHz				
External (Auxiliary Input) 50 Ω	250 mV from DC to 50 MHz, inc				
Trigger Characteristics					
A Event and Delayed B Event Trigger Types	Edge, Glitch, Runt, Width, Transition Time, Time-out, Pattern, State, Setup/Hold, Window – all except Edge, Pattern, and State can be Logic State qualified by up to two channels				
Main Trigger Modes	Auto, Normal,				
Trigger Sequences	Main, Delayed by Time, Delayed by Events, Reset by Tin can include separate horizontal delay after the trigge	ne, Reset by State, Reset by Transition. All sequences er event to position the acquisition window in time			
Clock Recovery System	Requires Option PTH or Option MTH	Standard			
Clock Recovery Phase Locked Loop Bandwidth	Fixed at FB	aud/1600			
Clock Recovery Frequency Range	1.5 MBaud to 3	3.125 GBaud			
8b10b Max Baud Rate	Requires Option PTU	Requires Option STU			
	5 GBa	aud			
Communications-related Triggers	Requires Option MTH	Standard			
	Support for AMI, HDB3, BnZS, CMI, MLT3 and NRZ encoded communications signals. Select among isolate positive or negative one, zero pulse form or eye patterns as applicable to the standard				
Serial Pattern Trigger	Requires Option PTH	Standard			
	Up to 64 bit serial word recognizer, bits specified in binary (high, low, don't care) or hex format. Trigger on NRZ-encoded data up to 1.25 GBaud				
	Trigger on 8b/10b-encoded data from 1.25 to 3.125 GBaud (40 bits)				
	Requires Option PTU	Requires Option STU			
	Trigger on 8b/10b-encoded da	ata up to 5 GBaud (40 bits)			
Threshold Range					
P6780	-2 to +				
P6717	–1.5 to				
Threshold Accuracy	±100 mV + 3% of	5			
Maximum I ² C, SPI Bus Toggle Rate	10 M				
Clock Recovery Jitter (RMS)	$<\!\!0.25\%$ bit period + 2 p_{RMM} $<\!\!0.25\%$ bit period + 1.5 p_{RMMS} for	r repeating "0011" data pattern			
Enhanced Triggering	User-selectable; enhanced triggering corrects path and the acquired data path (supports all P except pattern trigger); Not a	inpoint trigger types on both A- and B-Events			
Line	Trigger on power line sig				
Minimum Signal Amplitude needed for Clock Recovery	1 div _{p.p} up to 1.5 div _{p.p} above				
Tracking/Acquisition Range	±2% of reque	ested baud			
Trigger Coupling	DC, AC (attenua HF Rej (attenua LF Rej (attenuat Noise Reject (redi	ates >20 kHz) ies <200 kHz) uces sensitivity)			
Trigger Holdoff Range	250 ns min to	o 12 s max			
Trigger Level Range Internal	±120% of full scale fro	om center of screen			

Digital Phosphor Oscilloscopes / Digital Serial Analyzers / Mixed Signal Oscilloscopes

Trigger Modes

Mode	Analog Channels	MSO Logic Channels	Description
Comm	Х		Standard feature on the DSA70000B, provided as part of Option MTH on the DPO70000B and MSO70000 Series. Support for AMI, HDB3, BnZS, CMI, MLT3 and NRZ encoded signals
Bus	Х	Х	Trigger on a parallel, I ² C, or SPI bus when the specific bus value is found. (MSO70000 Series only)
Edge	Х	Х	Positive or negative slope on any channel or front panel auxiliary input. Coupling includes DC, AC, noise reject, HF reject, and LF reject
Glitch	Х	Х	Trigger on or reject glitches of positive, negative, or either polarity. Minimum glitch width is 150 ps (typical) with rearm time of 300 ps
Pattern	Х	Х	Trigger when pattern goes false or stays true for specified period of time. Pattern (AND, OR, NAND, NOR) specified for four input channels (and 16 logic channels on the MSO70000) defined as high, low, or don't care
Runt	Х		Trigger on a pulse that crosses one threshold but fails to cross a second threshold before crossing the first again. Event can be time- or logic-qualified
Serial Pattern	Х		Trigger on NRZ-encoded data up to 3.125 Gbaud (5 Gbaud with Option PTU or Option STU); above 1.25 Gbaud requires 8b/10b encoded data. Extended with pattern lock triggering to capture repeated acquisitions of long serial test patterns up to 6.25 Gb/s
Setup/Hold	Х		Trigger on violations of both setup time and hold time between clock and data present on any two input channels
State	Х	Х	Any logical pattern of channels (1, 2, 3) (and 16 logic channels on the MSO70000) clocked by edge on channel 4. Trigger on rising or falling clock edge
Time-out	Х	Х	Trigger on an event which remains high, low, or either, for a specified time period. Selectable from 300 ps
Transition	Х		Trigger on pulse edge rates that are faster or slower than specified. Slope may be positive, negative, or either
Trigger Delay by Events	Х	Х	1 to 2 billion events
Trigger Delay by Time	Х	Х	3.2 ns to 3 million seconds
Width	Х	Х	Trigger on width of positive or negative pulse either within or out of selectable time limits (down to 150 ps)
Window	Х		Trigger on an event that enters or exits a window defined by two user-adjustable thresholds. Event can be time or logic qualified

Search and Mark Events

Event	Description
Basic	Mark any events and document waveforms. Search positive, negative slopes or both on any channels. Event table summarizes all found events. All events are time stamped in reference to trigger position. Users can choose to stop acquisitions when an event is found
Advanced	Search glitches or runts, as well as transition rate, pulse width, setup and hold, time-out, window violations, or find any logic or state pattern on any number of channels. Search DDR read or write bursts with Option DDRA

Waveform Analysis

Waveform Measurements

Measurement	Description
Automatic Measurements	53, of which 8 can be displayed on screen at any one time; measurement statistics, user-definable reference levels, measurement within gates isolating the specific occurrence within an acquisition to measure
Amplitude Related	Amplitude, High, Low, Maximum, Minimum, Peak-to-Peak, Mean, Cycle Mean, RMS, Cycle RMS, Positive Overshoot, Negative Overshoot
Combination	Area, Cycle Area, Phase, Burst Width
Eye-pattern Related	Extinction Ratio (absolute, %, dB), Eye Height, Eye Width, Eye Top, Eye Base, Crossing %, Jitter (p-p, RMS, 6sigma), Noise (p-p, RMS), Signal/Noise Ratio, Cycle Distortion, Q-Factor
Histogram Related	Waveform Count, Hits in Box, Peak Hits, Median, Maximum, Minimum, Peak-to-Peak, Mean (μ), Standard Deviation (sigma), μ+1sigma, μ+2sigma, μ+3sigma
Time Related	Rise Time, Fall Time, Positive Width, Negative Width, Positive Duty Cycle, Negative Duty Cycle, Period, Frequency, Delay

Bus Decoding (MSO70000 only)

Characteristic	Description
Parallel	Data from selected channels is grouped as a parallel, multichannel bus and displayed as a single bus value. Display can be binary, hexadecimal, or symbolic formats
I ² C	SCLK and SDA channels are displayed as a bus per the Inter-Integrated Circuit specification
SPI	MOSI, MISO, SCLK, and SS channels are displayed as a bus per the Serial Peripheral Interface specification

Waveform Processing/Math

	6
Measurement	Description
Algebraic Expressions	Define extensive algebraic expressions including Waveforms, Scalars, User-adjustable Variables and Results of Parametric Measurements e.g. (Integral (CH.1–Mean(CH.1))×1.414×VAR1)
Arithmetic	Add, Subtract, Multiply, Divide Waveforms and Scalars
Filtering Functions	User-definable filters. Users specify a file containing the coefficients of the filter. Several example filter files are provided
Frequency Domain Functions	Spectral Magnitude and Phase, Real and Imaginary Spectra
Mask Function	Generates a Waveform Database pixmap from a sample waveform. Sample count can be defined
Math Functions	Average, Invert, Integrate, Differentiate, Square Root, Exponential, Log 10, Log e, Abs, Ceiling, Floor, Min, Max, Sin, Cos, Tan, ASin, ACos, ATan, Sinh, Cosh, Tanh
Relational	Boolean result of comparison >, <, \geq , \leq , ==, !=
Vertical Units	Magnitude: Linear, dB, dBm Phase: Degrees, radians, group delay IRE and mV units
Window Functions	Rectangular, Hamming, Hanning, Kaiser-Bessel, Blackman-Harris, Gaussian, Flattop2, Tek Exponential

Display, Computer, I/O

Display

Characteristic	Description
Color Palettes	Normal, Green, Gray, Temperature, Spectral, and User-defined
Display Format	YT, XY
Display Resolution	XGA 1024 horizontal × 768 vertical pixels
Display Size	Diagonal: 307.3 mm (12.1 in.)
Display Type	Liquid crystal active-matrix color display
Horizontal Divisions	10
Vertical Divisions	10
Waveform Styles	Vectors, Dots, Variable Persistance, Infinite Persistance

Computer System and Peripherals

Characteristic	DPO/DSA Models	MSO Models
Operating System	Microsoft Window	s XP Embedded
CPU	Intel Pentium 4 Processor, 3.4 GHz	Intel Core 2 Duo Processor, 3 GHz
PC System Memory	2 GB	4 GB
Hard Disk Drive	Rear-panel, removal 160 GB	
CD-R/W Drive	Front-panel CD-R/W d software a	
DVD Drive	Read	only
Mouse	Optical wheel mou	se, USB interface
Keyboard	USB int	erface

Input/Output Ports

Front Panel

Port	DPO/DSA Models	MSO Models
AUX Trigger Input	See trigger sp	ecifications
DC Probe Calibration Output	BNC connector, ±10 VDC (Signal available only due	
Fast Edge Output	SMA connector provides f ±20%; 810 mV (base to tr load; 440 mV ±20%	op) ±20% into ≥10 kΩ
Recovered Clock	SMA connector, ≤1.25 Gb/s, into 50 Ω at 1.25 Gb/s. or Option MTH to enable MSO70000, standar	Requires Option PTH on DPO70000B and
Recovered Data	SMA connector, ≤1.25 C 1010 repeating pattern 1.25 Gb/s. Requires O MTH to enable on DPO70 standard on D	200 mV into 50 $\tilde{\Omega}$ at ption PTH or Option 000B and MSO70000,
USB 2.0 Port	Allows connection of US or storage	

Rear Panel Port **DPO/DSA Models MSO Models** Miniature phone jacks for stereo microphone Audio Ports input and stereo line output AUX Trigger Output BNC connector, 0 to 3 V; default output is A-Event Trigger low true External Time Base BNC connector; allows time base system to phase lock to external 10/100 MHz reference. Optimized Reference In (by using a software switch) for either a highly stable clock or tracking mode **GPIB** Port IEEE 488.2 standard Keyboard Port PS/2 compatible LAN Port RJ-45 connector, supports 10Base-T, 100Base-T, and 1000Base-T PS/2 compatible Mouse Port Parallel Port IEEE 1284, DB-25 N/A connector eSATA port N/A External SATA interface for eSATA storage devices Power 100 to 240 V_{RMS}, ±10%, 50/60 Hz; 115 V_{RMS} ±10%, <870 W, 400 Hz; CAT II, <1100 VA typical External Video Ports Connect to show the oscilloscope display, including live waveforms on an external monitor or projector. The primary Windows desktop can also be displayed on an external monitor using these ports Scope XGA Video Port 15 pin D-sub connector N/A on the rear panel, video is IBM XGA compatible **DVI-I Video Port** N/A DVI connector, female. DVI to VGA 15 pin D-sub connector adapter provided Serial Port DB-9 COM1 port Two DB-9 COM1 ports TekLink™ Synchronizes multiple Tektronix oscilloscopes together to allow simultaneous acquisition of more than four channels Time Base Reference Out BNC connector; provides TTL-compatible output of internal 10 MHz reference oscillator USB 2.0 Ports Four. Allow connection of USB keyboard, mouse, or storage device Windows Video Port 15 pin D-sub connector on N/A the rear panel; connects a second monitor to use dual-monitor display mode allowing analysis results and plots to be viewed along with the oscilloscope display.

Video is DDC2B compliant

Physical Characteristics

Dimensions

Benchtop Configuration	mm	in.
Height	298	11.74
Width	451	17.75
Depth	489.97	19.29
Weight	kg	lb.
Net	24	53
Shipping	34	67
Rackmount	mm	in.
Configuration		
Height	311	12.25
Width	480.1	18.9
Depth (from rack mounting ear to back of instrument)	546.1	21.5
Weight	kg	lb.
Net	22	59
Kit	2.7	6

Mechanical

Cooling – Required Clearance	mm	in.
Тор	0	0
Bottom	0	0
Left side	76	3
Right side	76	3
Front	0	0
Rear	0	0

Environmental

Characteristic	Description
Temperature	
Operating	5 °C to +45 °C
Nonoperating	–20 °C to +60 °C
Humidity	
Operating	8% to 80% relative humidity (RH) at up to 32 °C Above +32 °C up to +45 °C; as limited by a 29.4 °C wet bulb temperature
Nonoperating	5% to 95% relative humidity (RH) Above +32 °C up to +60 °C; as limited by a 29.4 °C wet bulb temperature
Altitude	
Operating	3,000 m (9,843 ft.)
Nonoperating	12,000 m (39,370 ft.)
Regulatory	
Electromagnetic Compatibility	2004/108/EC; EN 61326-2-1:2006
Certifications	UL 61010-1, CSA 61010-1-04, LVD 2006/95/EC, EN61010-1, IEC 61010-1

Ordering Information

DSA72004B

Models	
Model	Description
MSO70404	4 GHz Mixed Signal Oscilloscope
MSO70604	6 GHz Mixed Signal Oscilloscope
MSO70804	8 GHz Mixed Signal Oscilloscope
MSO71254	12.5 GHz Mixed Signal Oscilloscope
MSO71604	16 GHz Mixed Signal Oscilloscope
MSO72004	20 GHz Mixed Signal Oscilloscope
DPO70404B	4 GHz Digital Phosphor Oscilloscope
DPO70604B	6 GHz Digital Phosphor Oscilloscope
DPO70804B	8 GHz Digital Phosphor Oscilloscope
DPO71254B	12.5 GHz Digital Phosphor Oscilloscope
DPO71604B	16 GHz Digital Phosphor Oscilloscope
DPO72004B	20 GHz Digital Phosphor Oscilloscope
DSA70404B	4 GHz Digital Serial Analyzer
DSA70604B	6 GHz Digital Serial Analyzer
DSA70804B	8 GHz Digital Serial Analyzer
DSA71254B	12.5 GHz Digital Serial Analyzer
DSA71604B	16 GHz Digital Serial Analyzer

All Models Include: Accessory pouch, front cover, mouse, keyboard, quick start user manual (071-173x-xx), (4) TekConnect* to 2.92 mm adapters (TCA-292MM) and (1) Tekconnect-to-BNC adapter (TCA-BNC), DPO70000B Series product software CD/DVD-ROM, Optional applications software CD/DVD-ROM, performance verification procedure PDF file, GPIB programmer's reference (on product software CD/DVD-ROM), calibration certificate documenting NIST traceability, Z 540-1 compliance and ISO9001, power cord, one-year warranty. Note: Please specify quick-start user manual language and power plug when ordering.

20 GHz Digital Serial Analyzer

Options

Instrument Options

Instrument Option	ns			
Option	DPO70000B	DSA70000B	MSO70000	Description
Record Length Opt				
Opt. 2XL	Х	Standard	Х	20 MS/Ch
Opt. 5XL	Х	Х	Х	50 MS/Ch
Opt. 10XL	Х	Х	Х	125 MS/Ch
Opt. 20XL*7	Х	Х	Х	250 MS/Ch
MSO70000 Digital S	ignal Analyzer Options			
Opt. DSAH			X, for MSO70404, MSO70604, or MSO70804	MSO Digital Signal Analysis Bundle, includes Opt. 2XL, ASM, DJA, MTH, and PTH
Opt. DSAU			X, for MSO71254, MSO71604, or MSO72004	MSO Digital Signal Analysis Bundle, includes Opt. 2XL, ASM, DJA, MTH, and PTH
Trigger and Search	Options			
Opt. ASM	Х	Standard	Х	Advanced Event Search and Mark
Opt. LT	Х	Х	Х	Waveform Limit Testing
Opt. MTH	Х	Standard	Х	Mask testing for Serial Standards up to 6 Gb/s. Includes hardware clock recovery for up to 5 Gb/s
Opt. PTH	Х	Standard	Х	Protocol Triggering and Decoding for 8b/10b-encoded Serial Signals up to 3.125 Gb/s. Includes hardware clock recovery and pattern lock triggering
Opt. PTU	Х		Х	Protocol Triggering and Decoding for 8b/10b-encoded Serial Signals up to 5 Gb/s
Opt. STU		Х		Protocol Triggering and Decoding for 8b/10b-encoded Serial Signals up to 5 Gb/s
Advanced Analysis	Options			
Opt. DDRA*8	Х	Х	Х	DDR Memory Bus Analysis
Opt. DJA	Х	Standard	Х	DPOJET Jitter and Eye Diagram Analysis
Opt. DSPT*10	Х	Х	Х	DisplayPort Compliance Test Solution
Opt. DVI	Х	Х	Х	DVI Compliance Test Solution
Opt. ET3*3	Х	Х	Х	Ethernet Compliance Test Software
Opt. HEAC	Х	Х	Х	HEAC Automated Solution
Opt. HT3	Х	Х	Х	HDMI Compliance Test Software
Opt. HT3DS	Х	Х	Х	HDMI Direct Synthesis for HDMI 1.4
Opt. IBA*6	Х	Х	Х	InfiniBand Compliance Module for RT-Eye Analysis Software
Opt. PCE*11	Х	Х	Х	PCI Express [™] Analysis Software
Opt. PWR*5	Х	Х	Х	Power Measurement and Analysis Software
Opt. RTE	Х	Х	Х	RT-Eye Serial Data Compliance and Analysis Software
Opt. SLA	Х	Х	Х	Serial Data Link Analysis Advanced (with Equalization)
Opt. SLE	Х	Х	Х	Serial Data Link Analysis Essentials (no Equalization)
Opt. SST ^{*6}	Х	Х	Х	SATA and SAS Analysis Software Module for RT-Eye Analysis Software
Opt. SVE	Х	Х	Х	SignalVu™ Essentials – Vector Signal Analysis Software
Opt. SVM*9	Х	Х	Х	General Purpose Modulation Analysis. Requires Opt. SVE
Opt. SVP*9	Х	Х	Х	Advanced Signal Analysis (including pulse measurements). Requires Opt. SVE
Opt. USB*4	Х	Х	Х	USB 2.0 Compliance Test Software
Opt. USB3*11	Х	Х	Х	USB 3.0 Compliance and Analysis Software
Opt. UWB	Х	Х	Х	Ultra Wideband Spectral Analysis (includes WiMedia Alliance PHY interf. testing)
Opt. UWBE	Х	Х	Х	Ultra Wideband Spectral Analysis Essentials
	Х	Х	Х	10GBase-T Automated Solution
Opt. UWBE Opt. XGbT				Ultra Wideband Spectral Analysis Essentials

Digital Phosphor Oscilloscopes / Digital Serial Analyzers / Mixed Signal Oscilloscopes

Option	DPO70000B	DSA70000B	MSO70000	Description
TekExpress Applicat	ion Framework Options			
Opt. TEKEXP	Х	Х	Х	TekExpress Automation Framework
Opt. SATA-TSG*12	Х	Х	Х	SATA PHY/TSG/OOB Transmitter Tests for TekExpress
Opt. SATA-RSG*12	Х	Х	Х	SATA RSG/RMT Receiver Tests for TekExpress
Opt. SATA-RXTX*12	Х	Х	Х	SATA Rx/Tx Channel Tests for TekExpress
Opt. SATA-DHB*12	Х	Х	Х	SATA TekExpress SW Bundle (TSG, RSG, RXTX for Hosts or Devices)
Opt. SATA-SI*12	Х	Х	Х	SATA SI Cable Tests for TekExpress
Opt. USB-TX*12	Х	Х	Х	TekExpress Automated USB 3.0 Solution

*3 Requires Ethernet Test Fixture.

*4 Requires TDSUSBF (USB Test Fixture).

 \star5 At least Opt. 2XL and a TCA-1MEG TekConnect 1 M Ω buffer amplifier are recommended for use.

*6 Requires Opt. RTE.

^{*7} For models of bandwidth ≥12.5 GHz only.

*8 Requires DJA and ASM.

*9 Requires Opt. SVE, SVEH, or SVEU.

^{*10} For models of bandwidth ≥8 GHz only.

*11 Requires Opt. DJA on DPO70000B and MSO70000 Series.

*12 Requires TekExpress Automation Framework.

User Manual Options

Option	Description
Opt. L0	English manual
Opt. L1	French manual
Opt. L3	German manual
Opt. L5	Japanese manual
Opt. L7	Simple Chinese manual
Opt. L8	Standard Chinese manual
Opt. L9	Korean manual
Opt. L10	Russian manual
Opt. L99	No manual

Power Plug Options

Option	Description
Opt. A0	US plug, 115 V, 60 Hz
Opt. A1	Euro plug, 220 V, 50 Hz
Opt. A2	UK plug, 240 V, 50 Hz
Opt. A3	Australian plug, 240 V, 50 Hz
Opt. A5	Swiss plug, 220 V, 50 Hz
Opt. A6	Japanese plug, 100 V, 110/120 V, 60 Hz
Opt. A10	China plug, 50 Hz
Opt. A11	India plug, 50 Hz
Opt. A99	No power cord

Service Options	
Option	Description
Opt. CA1	Single calibration or functional verification
Opt. C3	Calibration Service 3 Years
Opt. C5	Calibration Service 5 Years
Opt. D1	Calibration Data Report
Opt. D3	Calibration Data Report 3 Years (with Opt. C3)
Opt. D5	Calibration Data Report 5 Years (with Opt. C5)
Opt. R3	Repair Service 3 Years
Opt. R5	Repair Service 5 Years
Opt. IN	Product Installation Service
Opt. IF	Upgrade Installation Service

Recommended Accessories

Probes

Probe	Description
P7520	20 GHz TriMode™ probe
P7516	16 GHz TriMode™ probe
P7513A	13 GHz TriMode™ probe
P7313SMA	13 GHz TekConnect® differential SMA probe
P7508	8 GHz TriMode™ probe
P7380SMA	8 GHz TekConnect [®] differential SMA probe
P7506	6 GHz TriMode™ probe
P7504	4 GHz TriMode™ probe
P6780	Differential Input Logic probe
P6717	General Purpose Logic probe
P6251	DC to 1 GHz, 42 V, Differential Probe (requires TCA-BNC adapter)
P6250	DC to 500 MHz, 42 V, Differential Probe (requires TCA-BNC adapter)
TCPA300/TCPA400 Series	Current measurement systems
P5200/P5205/P5210	High-voltage differential probes

Adapters

Adapter	Description
TCA-1MEG	TekConnect high-impedance buffer amplifier. Includes P6139A passive probe
TCA-292MM	TekConnect to 2.92 mm connectors
TCA-BNC	TekConnect-to-BNC adapter
TCA-N	TekConnect-to-N adapter
TCA-SMA	TekConnect-to-SMA adapter
TCA75	8 GHz precision TekConnect 75 Ω to 50 Ω adapter with 75 Ω BNC input connector

Cables

Cable	Order Number
Centronics Cable	012-1214-xx
GPIB Cable (1 m)	012-0991-xx
GPIB Cable (2 m)	012-0991-xx
RS-232 Cable	012-1298-xx

Accessories

Accessory	Order Number
D-MAX Probe Footprint to Square Pin Header Adapter	NEX-P6960PIN
MICTOR to Square Pin Header Adapter	NEX-HD2HEADER
DDR3 ×4/×8 Solder Chip Interposer	NEX-DDR3MP78BSC
DDR3 ×4/×8 Socket Chip Interposer	NEX-DDR3MP78BSCK
DDR3 ×16 Solder Chip Interposer	NEX-DDR3MP96BSC
DDR3 ×16 Socket Chip Interposer	NEX-DDR3MP96BSCK
DDR2 ×4/×8 Solder Chip Interposer	NEX-DDR2MP60BSC
DDR2 ×4/×8 Socket Chip Interposer	NEX-DDR2MP60BSCK
DDR2 ×16 Solder Chip Interposer	NEX-DDR2MP84BSC
DDR2 ×16 Socket Chip Interposer	NEX-DDR2MP84BSCK
Spare HDD for DPO/DSA70000B and MSO70000 Series	065-0834-xx
Test Fixture for Use with Opt. USB	TDSUSBF
10GBase-T Fixture for Use with Option XGbT Software	TF-XGbT
Ethernet Test Fixture	Order through Crescent Heart Software (http://www.c-h-s.com)
Instrumented DIMM for DDR3	Order Scope NEXVu card for UDIMM Raw Card E. (Contact http://www.nexustechnology.com)
Oscilloscope Cart	K4000
Analog Probe Calibration and Deskew Fixture (4 GHz)	067-0484-xx
Analog Probe Deskew Fixture (>4 GHz)	067-1586-xx
Logic Probe Calibration and Deskew Fixture for MSO70000	878-0301-xx
Power Deskew Fixture	067-1686-xx
Rackmount Kit	016-1985-xx
Service Manual	071-1740-xx
Transit Case	016-1977-xx

Instrument Upgrades

The DPO70000B/DSA70000B and MSO70000 instruments can be easily upgraded after initial time of purchase.

To upgrade an existing DPO70000B, DSA70000B, or MSO70000 order the appropriate model number and option listed below. For example, DPO7UP DDRA.

Upgrade Model Numbers

DP070000B	DSA70000B	MSO70000
DP07UP	DP07UP	DPO-UP

Upgrade Options

Option	Description
Memory	Description
	n a DPO70000B or MSO70000 Series from:
XL02	Standard Configuration to Option 2XL Configuration
XL02	Standard Configuration to Option 5XL Configuration
XL010	Standard Configuration to Option 10XL Configuration
XL010 XL020*7	Standard Configuration to Option 20XL Configuration
	n a DPO70000B, DSA70000B, or MSO70000 Series from:
XL25	Option 2XL Configuration to Option 5XL Configuration
XL210	Option 2XL Configuration to Option 10XL Configuration
XL220*7	Option 2XL Configuration to Option 10XL Configuration
XL510	Opt. 5XL Configuration to Opt. 10XL Configuration
XL520*7	Opt. 5XL Configuration to Opt. 20XL Configuration
XL1020*7	Opt. 10XL Configuration to Opt. 20XL Configuration
Trigger and Search	
10	SA70000B, or MSO70000 Series with:
ASM*13	Advanced Event Search and Mark
LT	Waveform Limit Testing
MTH*13	Mask testing for Serial Standards with Hardware Clock Recovery
PTH*13	Protocol Triggering and Decoding for 8b/10b-encoded Serial Signals (Up to 3.125 Gb/s)
PTU ^{*14}	Protocol Triggering and Decoding for 8b/10b-encoded Serial Signals (Up to 5 Gb/s)
STU*15	Protocol Triggering and Decoding for 8b/10b-encoded Serial Signals (Up to 5 Gb/s)
Advanced Analysis	
Upgrade DPO70000B, D	SA70000B, or MSO70000 Series with:
CP2*16	ANSI/ITU Telecom Pulse Compliance Testing Software
DDRA*17	Upgrade to Option DDRA
DJAH	DPOJET Jitter and Eye Diagram Analysis (Upgrade for DPO70404B – DPO70804B or MSO70404 – MSO70804 models)
UAU	DPOJET Jitter and Eye Diagram Analysis (Upgrade for DPO71254B – DPO72004B or MSO71254 – MSO72004 models)
RJUP	Upgrade DSA70000B with RT-Eye Serial Data Compliance and Analysis Software
DSAH	MSO Digital Signal Analysis Bundle (Upgrade for MSO70404 – MSO70804 models)

Option	Description
DSAU	MSO Digital Signal Analysis Bundle (Upgrade for MSO71254 – MSO72004 models)
DSPT	DisplayPort Compliance Test Solution
DVI	DVI Compliance Test Solution
EQ*18	Equalization to Upgrade from Option SLE to Option SLA
ET3	Ethernet Compliance Test Software
HEAC	HEAC Automated Solution
HT3	HDMI Compliance Test Software
HT3DS	HDMI Direct Synthesis for HDMI 1.4
IBA*6	InfiniBand Compliance Module for RT-Eye Analysis Software
J2	TDSDDM2 Disk-drive Analysis Software
JA3	TDSJIT3 Advanced Jitter and Timing Measurements Software
JE3	TDSJIT3 Essentials Jitter And Timing Measurements
JEA	Upgrade From Jitter Essentials to Jitter Advanced
PCE ^{*19}	PCI Express™ Analysis Software
PTD	Protocol Decoding for 8b/10b-encoded Serial Signals
PWR	Power Measurement and Analysis Software
RTE	RT-Eye Serial Data Compliance and Analysis Software
SLA	Serial Data Link Analysis Advanced (with Equalization)
SLE	Serial Data Link Analysis Essentials (No Equalization)
SST*6	SATA and SAS Analysis Software Module for RT-Eye Analysis Software
SVEH*20	SignalVu™ Essentials – Vector Signal Analysis Software
SVEU*7	SignalVu™ Essentials – Vector Signal Analysis Software
SVM	General Purpose Modulation Analysis. Requires Option SVE
SVP	Advanced Pulsed Signal Analysis including Measurements. Requires Option SVE
USB	USB 2.0 Compliance Test Software
USB3*21	USB 3.0 Compliance and Analysis Software
UWB	Ultra-Wideband Spectral Analysis (includes WiMedia Alliance PHY interf. testing)
UWBE	Ultra-Wideband Spectral Analysis Essentials
VNM*22	TDSVNM CAN and LIN Timing and Protocol Decode (Triggering not included)
XGbT	10GBase-T Automated Solution
IF	Upgrade Installation Service

*6 Requires Opt. RTE.

^{*7} For models of bandwidth ≥12.5 GHz only.

*13 Standard feature on DSA70000B models.

 $^{\star 14}$ For DPO70000B and MSO70000 models only.

*15 For DSA70000B models only.

*16 Requires Opt. MTH.

*17 Requires Opt. ASM and DJA.

*18 Requires Opt. SLE.

*19 Requires. Opt. RTE or DJA.

*20 For models of bandwidth ≤8 GHz only.

*21 Requires Opt. DJA.

*22 CAN/LIN trigger module available - Order ATM1 through Crescent Heart Software.

Instrument Bandwidth Upgrades

The analog bandwidth of the DPO70000B, DSA70000B, and MSO70000 instruments can be easily upgraded after initial time of purchase. To upgrade your instrument's bandwidth, order one of the products listed below.

DPO70000B and DSA70000B Series		
Current Bandwidth	Bandwidth After Upgrade	Model Number
4 GHz	6 GHz	BWU4T6
4 GHz	8 GHz	BWU4T8
4 GHz	12.5 GHz	BWU4T12
4 GHz	16 GHz	BWU4T16
4 GHz	20 GHz	BWU4T20
6 GHz	8 GHz	BWU6T8
6 GHz	12.5 GHz	BWU6T12
6 GHz	16 GHz	BWU6T16
6 GHz	20 GHz	BWU6T20
8 GHz	12.5 GHz	BWU8T12
8 GHz	16 GHz	BWU8T16
8 GHz	20 GHz	BWU8T20
12.5 GHz	16 GHz	BWU12T16
12.5 GHz	20 GHz	BWU12T20
16 GHz	20 GHz	BWU16T20
MSO70000 Series		
Current Bandwidth	Bandwidth After Upgrade	Model Number
4 GHz	6 GHz	MBWU4T6
4 GHz	8 GHz	MBWU4T8
4 GHz	12.5 GHz	MBWU4T12
4 GHz	16 GHz	MBWU4T16
4 GHz	20 GHz	MBWU4T20
6 GHz	8 GHz	MBWU6T8
6 GHz	12.5 GHz	MBWU6T12
6 GHz	16 GHz	MBWU6T16
6 GHz	20 GHz	MBWU6T20

ce



8 GHz

8 GHz

8 GHz 12.5 GHz

12.5 GHz

16 GHz

Product(s) are manufactured in ISO registered facilities.

12.5 GHz

16 GHz 20 GHz

16 GHz

20 GHz

20 GHz

MBWU8T12 MBWU8T16

MBWU8T20

MBWU12T16

MBWU12T20

MBWU16T20

GPIB IEEE-488 Product(s) complies with IEEE Standard 488.1-1987, RS-232-C, and with Tektronix Standard Codes and Formats.

Digital Phosphor Oscilloscopes / Digital Serial Analyzers / Mixed Signal Oscilloscopes

Contact Tektronix:

Data Sheet

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For other areas contact Tektronix, Inc at: 1 (503) 627-7111

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For Further Information. Tektronix maintains a comprehensive, constantly expanding collection of application notes, technical briefs and other resources to help engineers working on the cutting edge of technology. Please visit www.tektronix.com

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